



## EMC COMPLIANCE TEST REPORT

for

### 586 CPU Board

Trade Name : ADVANTECH

Model Number : PCA- 5822

Serial Number : N/A

Report Number : 990647-E

Date : January 7, 2000

Regulations : See below

Standards	Results (Pass/Fail)
EN 55022: 1994 + A1: 1995 + A2: 1997 (Class A)	PASS
EN 61000-3-2: 1995 + A1: 1998 + A2: 1998	PASS
EN 61000-3-3 :1995	PASS
<b>EN 50082-2: 1995</b>	<b>PASS</b>
- EN 61000-4-2: 1995	PASS
- ENV 50140: 1994	PASS
- ENV 50204: 1996	PASS
- EN 61000-4-4:1995	PASS
- ENV 50141: 1994	PASS
- EN 61000-4-8: 1993	N/A

Prepared for :

**Advantech Co., Ltd.**

**4<sup>th</sup> FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,  
Taipei Hsien, Taiwan, R.O.C.**

Prepared by :



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## EC-Declaration of Conformity

For the following equipment:

586 CPU Board

( Product Name )

PCA-5822 / ADVANTECH

( Model Designation / Trade name )

Advantech Co., Ltd.

( Manufacturer Name )

4<sup>th</sup> FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City, Taipei Hsien, Taiwan, R.O.C.

(Manufacturer Address)

is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the Laws of the Member States relating to Electromagnetic Compatibility Directive (89/336/EEC, Amended by 92/31/EEC & 93/68/EEC), For the evaluation regarding the Electromagnetic Compatibility (89/336/EEC, Amended by 92/31/EEC & 93/68/EEC), the following standards are applied:

☒ EN 55022: 1994 + A1: 1995 + A2: 1997 (Class A)

☒ EN 61000-3-2: 1995 + A1: 1998 + A2: 1998

☒ EN 61000-3-3: 1995

☒ EN 50082-2: 1995

EN 61000-4-2: 1995 ; ENV 50140: 1994 ; ENV 50204: 1996 ; EN 61000-4-4: 1995

ENV 50141: 1994

The following manufacturer / importer or authorized representative established within the EUT is responsible for this declaration:

( Company Name )

( Company Address )

Person responsible for making this declaration:

( Name, Surname )

( Position / Title )

( Place )

( Date )

( Legal Signature )

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## VERIFICATION OF COMPLIANCE

**Equipment Under Test:** 586 CPU Board  
**Trade Name:** ADVANTECH  
**Model Number:** PCA-5822  
**Serial Number:** N/A  
**EUT Powered during test:** 230VAC/50Hz  
**Applicant:** **Advantech Co., Ltd.**  
4<sup>th</sup> FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,  
Taipei Hsien, Taiwan, R.O.C.  
**Manufacturer:** **Advantech Co., Ltd.**  
4<sup>th</sup> FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,  
Taipei Hsien, Taiwan, R.O.C.  
**Type of Test:** EMC Directive 89/336/EEC for CE Marking  
**Technical Standards:** EN 55022: 1994 + A1: 1995 + A2: 1997 (Class A)  
EN 61000-3-2: 1995 + A1: 1998 + A2: 1998, EN 61000-3-3: 1995  
EN 50082-2: 1995 (EN 61000-4-2: 1995, ENV 50140: 1994,  
ENV 50141: 1994, EN 61000-4-4: 1995,  
ENV 50204: 1996)  
**File Number:** 990647-E  
**Date of test:** Dec. 28 - Jan. 5, 2000  
**Tested by:** Gimmy Tsai  
**Deviation:** According applicant declaration this EUT is a class A product, and to  
market in industrial environment only.  
**Condition of Test Sample:** Normal

The above equipment was tested by C&C Laboratory Co., Ltd. for compliance with the requirements set forth in EMC Directive 89/336/EEC and the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

The test results of this report relate only to the tested sample identified in this report.

Approved by Authorized Signatory: Kurt Chen  
**Kurt Chen / Q.A. Manager**

## GENERAL INFORMATION

**Applicant:** **Advantech Co., Ltd.**  
4<sup>th</sup> FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,  
Taipei Hsien, Taiwan, R.O.C.

**Contact Person:** John Chou

**Manufacturer:** **Advantech Co., Ltd.**  
4<sup>th</sup> FL., No. 108-3 Ming-Chuan Road, Hsin-Tien City,  
Taipei Hsien, Taiwan, R.O.C.

**File Number:** 990647-E

**Date of Test:** Dec. 28 - Jan.5, 2000

**Equipment Under Test:** 586 CPU Board

**Model Number:** PCA-5822

**Serial Number:** N/A

**Technical Standards:** EN 55022: 1994 + A1: 1995 + A2: 1997 (Class A)  
EN 61000-3-2: 1995 + A1: 1998 + A2: 1998, EN 61000-3-3: 1995  
EN 50082-2: 1995 (EN 61000-4-2: 1995, ENV 50140: 1994,  
ENV 50141: 1994, EN 61000-4-4: 1995,  
ENV 50204: 1996)

**Frequency Range  
(EN 55011):** 150Khz to 30MHz for Line Conducted Test  
30MHz to 1000MHz for Radiated Emission Test

**Test Site** **C & C LABORATORY CO., LTD.**  
No. 15, 14 Lin, Chi Twu Chi, Lu-Chu Hsiang  
Taoyuan, Taiwan, R. O. C.

## **SYSTEM DESCRIPTION**

### **EUT Test Program:**

1. An EMI test software was loaded and executed under Windows environment.
2. The EMI test program sequentially exercised all I/O's of EUT.
3. A communicated software was loaded and executed to communicate between EUT and remote side.
4. The EUT sends and receives message from remote side, and filling the screen of monitor with upper case of "H" patterns.
5. Repeat step 2 to 4 throughout the test.

## PRODUCT INFORMATION

**Housing Type:** N/A  
**EUT Power Rating:** DCV from Power Supply  
**AC power during Test:** 230VAC/50Hz  
**Power Supply Manufacturer:** ADVANTECH  
**Power Supply Model Number:** PS50A  
**AC Power Cord Type:** Unshielded, 1.8m (Detachable) to Power Supply  
**DC Power Cable Type:** N/A  
**CPU Manufacturer:** Cyrix MediaGX      **Type:** MMX-S 200 MHz  
**OSC/Clock Frequencies :** 33 MHz  
**Memory Capacity:**      **Installed:** 64 MB  
**HDD Manufacturer:** IBM-DBCA      **Model:** 203240  
**Chassis Manufacturer:** ADVANTECH      **Model:** MDPC-200  
**I/O Board Type:** On Board  
**VGA Card Type:** On Board

### I/O Port of EUT:

I/O PORT TYPES	Q'TY	TESTED WITH
1). Video Port	1	1
2). PS/2 Keyboard	1	1
3). TV Port	1	1
4). S-TV Port	1	1
5). LAN Port	1	1
6). Serial Port	1	1

Note: The EUT was installed a computer simulation box for all tests.



## SUPPORT EQUIPMENT

No.	Equipment	Model #	Serial #	FCC ID	Trade Name	Data Cable	Power Cord
1	Monitor	CM-753ET	T9A000038	FCC DoC	HITACHI	Shielded, 1.8m with two cores	Unshielded, 1.8m
2	TV	21B4ST	62233362	N/A	TOSHIBA	Unshielded, 1.8m	Unshielded, 1.8m
3	PS/2 Keyboard	KB-9000	9809048153	LFCACEKEY1	ACEKEY	Shielded, 1.5m	N/A
4	Serial Mouse	N/A	SL-A 799109	E6QMOUSE X31	N/A	Shielded, 1.5m	N/A
5	HUB (Remote)	J2600A	SG43801953	N/A	HP	Shielded, 20m	N/A
6	PC (Remote)	D84XX	SG93000552	FCC DoC	HP	Shielded, 2m	N/A
7	Monitor (Remote)	D2827A	KR92316215	C5F7NFCMC151 8X	HP	Shielded, 1.5m	N/A
8	PS/2 Keyboard (Remote)	KB-9000	9809048156	LFCACEKEY1	ACEKEY	Shielded, 1.5m	N/A
9	USB Mouse (Remote)	M-BB48	LZE93050079	FCC DoC	LOGITECH	Shielded, 1.8m	N/A

**Note:** All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

**Grounding:** Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

## TEST FACILITY

- Location:** No. 15, 14 Line, Chin Twu Chi, Lu Chu Hsiang, Taoyuan, Taiwan, R.O.C.
- Description:** There are three 3/10m open area test sites and three line conducted labs for final test, and one 3/10m open area test site for engineering lab. The Open Area Test Sites and the Line Conducted labs are constructed and calibrated to meet the FCC requirements in documents ANSI C63.4: 1992 and CISPR 22/EN 55022 requirements.
- Site Filing:** A site description is on file with the Federal Communications Commission, 7435 Oakland Mills Road, Columbia, MD 21046.
- Registration also was made with Voluntary Control Council for Interference (VCCI).
- Site Accreditation:** Accredited by NEMKO (Authorization #: ELA 124) for EMC & A2LA (Certificate #: 824.01) for Emission
- Also accredited by BSMI for the product category of Information Technology Equipment.
- Instrument Tolerance:** All measuring equipment is in accord with ANSI C63.4 and CISPR 22 requirements that meet industry regulatory agency and accreditation agency requirement.
- Ground Plane:** Two conductive reference ground planes were used during the Line Conducted Emission, one in vertical and the other in horizontal. The dimensions of these ground planes are as below. The vertical ground plane was placed distancing 40 cm to the rear of the wooden test table on where the EUT and the support equipment were placed during test. The horizontal ground plane projected 50 cm beyond the footprint of the EUT system and distanced 80 cm to the wooden test table. For Radiated Emission Test, one horizontal conductive ground plane extended at least 1m beyond the periphery of the EUT and the largest measuring antenna, and covered the entire area between the EUT and the antenna. It has no holes or gaps having longitudinal dimensions larger than one-tenth of a wavelength at the highest frequency of measurement up to 1GHz.
- Site # 1 & # 3 Line Conducted Test Site:** Vertical ground plane (2.2m x 2.2m)  
Horizontal ground plane (2.5m x 2.5m)
- Site # 4 Line Conducted Test Site:** At Shielding Room

## TEST EQUIPMENT LIST

**Instrumentation:** The following list contains equipment used at C & C Laboratory, Co., Ltd. for testing. The equipment conforms to the CISPR 16-1 / ANSI C63.2-1988 Specifications for Electromagnetic Interference and Field Strength Instrumentation from 10kHz to 1.0 / 2.0 GHz.

### Equipment used during the tests:

Open Area Test Site: ☒ # 1 ; ☐ # 3 ; ☐ # 4

Open Area Test Site # 1					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	HP	8568B	3001A05004	04/16/1999	04/15/2000
S.P.A Display	HP	85662A	3104A18846	04/16/1999	04/15/2000
RF Pre-selector	HP	85685A	2947A01064	04/16/1999	04/15/2000
Q.P Adaptor	HP	85650A	2811A01399	04/16/1999	04/15/2000
Precision Dipole	R&S	HZ-12	846932/0004	06/16/1999	06/16/2000
Precision Dipole	R&S	HZ-13	846556/0008	06/16/1999	06/16/2000
Horn Antenna	EMCO	3115	9602-4659	04/04/1999	04/04/2000
Bilog Antenna	CHASE	CBL6112A	2309	04/05/1999	04/05/2000
Turn Table	EMCO	2081-1.21	N/A	N/A	N/A
Antenna Tower	EMCO	2075-2	9707-2604	N/A	N/A
Controller	EMCO	2090	N/A	N/A	N/A
RF Switch	ANRITSU	MP59B	N/A	N/A	N/A
Site NSA	C&C	N/A	N/A	11/10/1999	11/09/2000

Open Area Test Site # 3					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	ADVANTEST	R3261C	71720533	10/25/1999	10/24/2000
Pre-Amplifier	HP	8447D	2944A09173	01/28/1999	01/27/2000
EMI Test Receiver	R&S	ESCS30	847793/012	11/06/1999	11/05/2000
Precision Dipole	R&S	HZ-12	846932/0004	06/16/1999	06/16/2000
Precision Dipole	R&S	HZ-13	846556/0008	06/16/1999	06/16/2000
Horn Antenna	EMCO	3115	9602-4659	04/04/1999	04/04/2000
Bilog Antenna	CHASE	CBL6112A	2179	11/27/1999	11/26/2000
Turn Table	EMCO	2081-1.21	9709-1885	N/A	N/A
Antenna Tower	EMCO	2075-2	9707-2060	N/A	N/A
Controller	EMCO	2090	9709-1256	N/A	N/A
RF Switch	ANRITSU	MP59B	N/A	N/A	N/A
Site NSA	C&C	N/A	N/A	01/31/1999	01/31/2000

Open Area Test Site # 4					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	ADVANTEST	R3261C	81720301	09/02/1999	09/01/2000
Pre-Amplifier	HP	8447F	2944A03748	10/22/1999	10/21/2000
EMI Test Receiver	R&S	ESVS10	846285/016	12/07/1999	12/06/2000
Precision Dipole	R&S	HZ-12	846932/0004	06/16/1999	06/16/2000
Precision Dipole	R&S	HZ-13	846556/0008	06/16/1999	06/16/2000
Horn Antenna	EMCO	3115	9602-4659	04/04/1999	04/04/2000
Bilog Antenna	CHASE	CBL 6112B	2462	01/01/1999	01/01/2000
Turn Table	Chance most	N/A	N/A	N/A	N/A
Antenna Tower	Chance most	N/A	N/A	N/A	N/A
Controller	Chance most	N/A	N/A	N/A	N/A
RF Switch	ANRITSU	MP59B	N/A	N/A	N/A
Site NSA	C&C Lab.	N/A	N/A	12/26/1999	12/25/2000

Conducted Emission Test Site: ☐ # 1 ; ☐ # 3 ; ☒ # 4

Conducted Emission Test Site # 1					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
Spectrum Analyzer	HP	8568B	3001A05004	04/16/1999	04/15/2000
S.P.A Display	HP	85662A	3104A18846	04/16/1999	04/15/2000
RF Pre-selector	HP	85685A	2947A01064	04/16/1999	04/15/2000
Q.P Adaptor	HP	85650A	2811A01399	04/16/1999	04/15/2000
LISN	EMCO	3825/2	9106-1809	07/27/1999	07/26/2000
LISN	EMCO	3825/2	9106-1810	07/27/1999	07/26/2000

Conducted Emission Test Site # 3					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
EMI Test Receiver	R&S	ESCS30	847793/012	11/06/1999	11/05/2000
LISN	EMCO	3825/2	9003-1628	04/29/1999	04/28/2000
LISN	R&S	ESH3-Z5	848773/014	10/22/1999	10/21/2000

Conducted Emission Test Site # 4					
EQUIPMENT TYPE	* MFR	MODEL NUMBER	SERIAL NUMBER	LAST CAL.	CAL. DUE
EMI Test Receiver	R&S	ESHS10	843743/015	12/09/1999	12/08/2000
LISN	EMCO	3825/2	1382	01/09/1999	01/08/2000
LISN	R&S	ESH2-Z5	843250/010	12/06/1999	12/05/2000

The calibrations of the measuring instruments, including any accessories that may effect such calibration, are checked frequently to assure their accuracy. Adjustments are made and correction factors applied in accordance with instructions contained in the manual for the measuring instrument.

## TEST EQUIPMENT LIST

Power Harmonic & Voltage Fluctuation/Flicker Measurement Equipment				
MANUFACTURER / TYPE	MODEL NO.	SERIAL NO.	LAST CAL.	CAL. DUE
HAEFELY TRENCH Harmonic & Flicker Tester	PHF 555	080 419-25	Oct. 5, 1999	Oct. 5, 2000

ESD Immunity Test Equipment				
Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
EMV SYSTEM/ ESD Generator	SESD 2000	812006	Nov. 19, 1999	Nov. 18, 2000

Radiated Electromagnetic Field Immunity Test Equipment				
Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
Maconi /Signal Generator	2022D	119246/003	Aug. 17, 1999	Aug. 16, 2000
M2S / Power Amplifier	A00181/1000	9801-112	N/A	N/A
M2S / Power Amplifier	AC8113/800-250A	9801-179	N/A	N/A
Wandel & Goltormann/ EM-Radiation Meter	EMR-30	L-0013	Jan. 13, 1999	Jan. 12, 2000
EMCO Power Antenna	3141	9712-1083	N/A	N/A

Fast Transients/Burst Immunity Test Equipment				
Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
HAEFELY TRENCH/ Fast Transients/Burst Generator	PEFT-JUNIOR	583 333-117	Aug. 18, 1999	Aug. 18, 2000

Conducted Immunity Test Equipment				
Manufacturer/Type	Model No.	Serial No.	Last Cal.	Cal. Due
M2S / Power Amplifier	A00181/1000	9801-112	N/A	N/A
Maconi /Signal Generator	2022D	119246/003	Aug. 18, 1999	Aug. 18, 2000

## SECTION 1 EN 55011 (LINE CONDUCTED & RADIATED EMISSION)

### MEASUREMENT PROCEDURE (PRELIMINARY LINE CONDUCTED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55011: 1991 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55011: 1991.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55011: 1991.
- 4) The EUT received AC power through a Line Impedance Stabilization Network (LISN) which supplied power source of 230VAC/50Hz and was grounded to the ground plane.
- 5) All support equipment received power from a second LISN supplying power of 110VAC/60Hz, if any.
- 6) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to analyzer and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7) Analyzer / Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- 8) During the above scans, the emissions were maximized by cable manipulation.
- 9) The following test mode(s) were scanned during the preliminary test:

**Mode(s):**

1. TV Terminal + 800 x 600 resolution
2. S-TV Terminal + 800 x 600 resolution

- 10) After the preliminary scan, we found the following test model(s) producing the highest emission level.

**Model(s): 1.**

Then, the EUT configuration and cable configuration of the above highest emission level were recorded for reference of final testing.

## MEASUREMENT PROCEDURE (FINAL LINE CONDUCTED EMISSION TEST)

- 1) EUT and support equipment was set up on the test bench as per step 10 of the preliminary test.
- 2) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- 3) The test data of the worst case condition(s) was reported on the Summary Data page.

### Data Sample:

Freq. MHz	Q.P. Raw dBuV	Average Raw dBuV	Q.P. Limit dBuV	Average Limit dBuV	Q.P. Margin dB	Average Margin dB	Note
x.xx	39.2	---	79	66	-39.8	-26.8	L 1

Freq.	= Emission frequency in MHz
Raw dBuV	= Uncorrected Analyzer / Receiver reading
Limit dBuV	= Limit stated in standard
Margin dB	= Reading in reference to limit
Note	= Current carrying line of reading
“---”	= The emission level complied with the Average limits, with at least 2 dB margin, so no further recheck.

## LINE CONDUCTED EMISSION LIMIT

Frequency	Maximum RF Line Voltage	
	Q.P.	AVERAGE
150kHz-500kHz	79dBuV	66dBuV
500kHz-5MHz	73dBuV	60dBuV
5MHz-30MHz	73dBuV	60dBuV

**Note:** The lower limit shall apply at the transition frequency.



## MEASUREMENT PROCEDURE (PRELIMINARY RADIATED EMISSION TEST)

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane as per EN 55011: 1991 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN 55011: 1991.
- 3) All I/O cables were positioned to simulate typical actual usage as per EN 55011: 1991.
- 4) The EUT received 230VAC/50Hz power source from the outlet socket under the turntable. All support equipment received 110VAC/60Hz power from another socket under the turntable, if any.
- 5) The antenna was placed at some given distance away from the EUT as stated in EN 55011: 1991. The antenna connected to the analyzer via a cable and at times a pre-amplifier would be used.
- 6) The Analyzer quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 7) The following test mode(s) were scanned during the preliminary test:

**Mode(s):**

- 1. TV Terminal + 800 x 600 resolution**
- 2. S-TV Terminal + 800 x 600 resolution**

- 8) After the preliminary scan, we found the following test mode(s) producing the highest emission level.

**Mode(s): 1.**

Then, the EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for final testing.

## MEASUREMENT PROCEDURE (FINAL RADIATED EMISSION TEST)

- 1) EUT and support equipment were set up on the turntable as per step 8 of the preliminary test.
- 2) The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- 3) Recorded at least the six highest emissions. Emission frequency, amplitude, were recorded into a computer ( The antenna position, polarization and turntable position were kept in raw data file ) in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- 4) The test data of the worst case condition(s) was reported on the Summary Data page.

### Data Sample:

Freq. (MHz)	Raw Data (dBuV/m)	Corr. Factor (dB)	Emiss. Level ( dBuV/m )	Limits	Margin (dB)
xx.xx	14.0	11.2	26.2	40	-13.8

Freq.	= Emission frequency in MHz
Raw Data (dBuV/m)	= Uncorrected Analyzer / Receiver reading
Corr. Factor (dB)	= Correction factors of antenna factor and cable loss
Emiss. Level	= Raw reading converted to dBuV/m and CF added
Limit dBuV/m	= Limit stated in standard
Margin dB	= Reading in reference to limit

## RADIATED EMISSION LIMIT

Frequency (MHz)	Distance (m)	Maximum Field Strength Limit (dBuV/m/ Q.P.)
30-230	10	40
230-1000	10	47

**Note:** The lower limit shall apply at the transition frequency.

## BLOCK DIAGRAM OF TEST SETUP

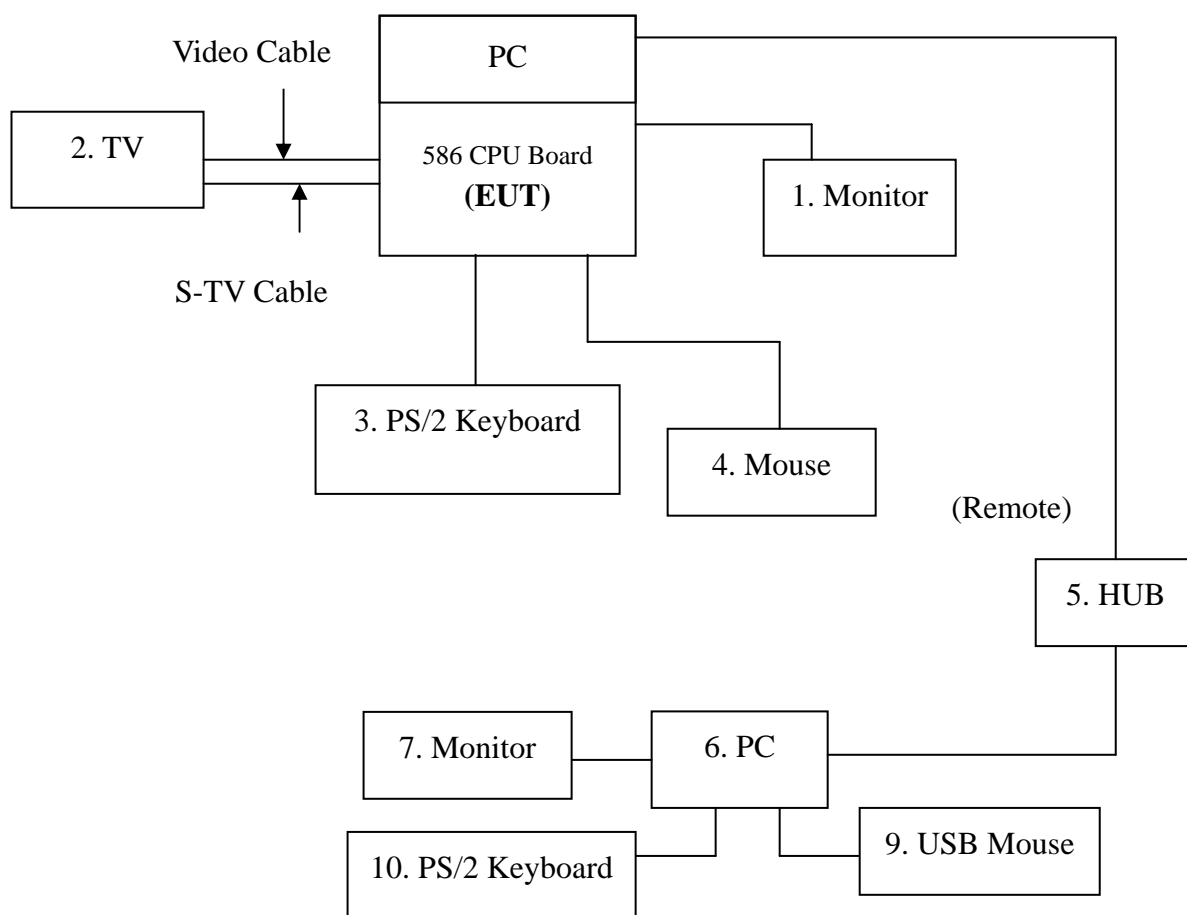
### SYSTEM DIAGRAM OF CONNECTIONS BETWEEN EUT AND SIMULATORS

**EUT:** 586 CPU Board

**Trade Name:** ADVANTECH

**Model Number:** PCA-5822

**Power Cord:** Unshielded, 1.8m



## SUMMARY DATA

### (LINE CONDUCTED TEST)

**Model Number:** PCA-5822

**Location:** Site # 4

**Tested by:** Gimmy Tsai

**Test Mode:** Mode 1

**Test Results:** Passed

**Temperature:** 16°C

**Humidity:** 58%RH

(The chart below shows the highest readings taken from the final data)

FREQ MHz	Q.P. Raw dBuV	AVG Raw dBuV	Q.P. Limit dBuV	AVG Limit dBuV	Q.P. Margin dB	AVG Margin dB	NOTE
2.273	39.4	---	73.0	60.0	-33.6	---	L1
3.588	65.7	57.3	73.0	60.0	-7.3	-2.7	L1
7.175	47.8	---	73.0	60.0	-25.2	---	L1
12.290	29.7	---	73.0	60.0	-43.3	---	L1
14.350	51.3	---	73.0	60.0	-21.7	---	L1
19.729	40.6	---	73.0	60.0	-32.4	---	L1
0.179	44.2	---	79.0	66.0	-34.8	---	L2
2.230	37.4	---	73.0	60.0	-35.6	---	L2
3.586	31.9	---	73.0	60.0	-41.1	---	L2
3.938	31.3	---	73.0	60.0	-41.7	---	L2
6.541	31.7	---	73.0	60.0	-41.3	---	L2
7.186	30.8	---	73.0	60.0	-42.2	---	L2

L1 = Line One (Hot side) / L2 = Line Two (Neutral side)

**\*\*NOTE: “---” denotes the emission level was or more than 2dB below the Average limit, so no re-check anymore.**

## SUMMARY DATA

### (RADIATED EMISSION TEST)

**Model Number:** PCA-5822

**Location:** Site # 1

**Tested by:** Gimmy Tsai

**Test Mode:** Mode 1

**Polar:** Vertical -- 10m

**Detector Function:** Quasi-Peak

**Test Results:** Passed

**Temperature:** 19°C

**Humidity:** 60%RH

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Raw Data (dBuV/m)	Corr. Factor (dB)	Emiss. Level ( dBuV/m )	Limits	Margin (dB)
133.97	13.1	15.2	28.3	40.0	-11.7
191.76	18.4	12.2	30.6	40.0	-9.4
192.55	20.8	12.1	32.9	40.0	-7.1
336.13	8.9	18.5	27.4	47.0	-19.6
382.64	9.9	20.1	30.0	47.0	-17.0
432.17	11.9	20.9	32.8	47.0	-14.2

## SUMMARY DATA

### (RADIATED EMISSION TEST)

**Model Number:** PCA-5822

**Location:** Site # 1

**Tested by:** Gimmy Tsai

**Test Mode:** Mode 1

**Polar:** Horizontal -- 10m

**Detector Function:** Quasi-Peak

**Test Results:** Passed

**Temperature:** 19°C

**Humidity:** 60%RH

(The chart below shows the highest readings taken from the final data)

Freq. (MHz)	Raw Data (dBuV/m)	Corr. Factor (dB)	Emiss. Level ( dBuV/m )	Limits	Margin (dB)
191.32	18.9	12.4	31.3	40.0	-8.7
192.41	22.0	12.4	34.4	40.0	-5.6
214.81	9.5	10.4	19.9	40.0	-20.1
336.15	12.4	18.4	30.8	47.0	-16.2
382.63	12.7	20.8	33.5	47.0	-13.5
432.15	17.5	22.0	39.5	47.0	-7.5

## SECTION 2 EN 61000-3-2 & EN 61000-3-3 (POWER HARMONICS & VOLTAGE FLUCTUATION/FLICKER)

### POWER HARMONICS MEASUREMENT

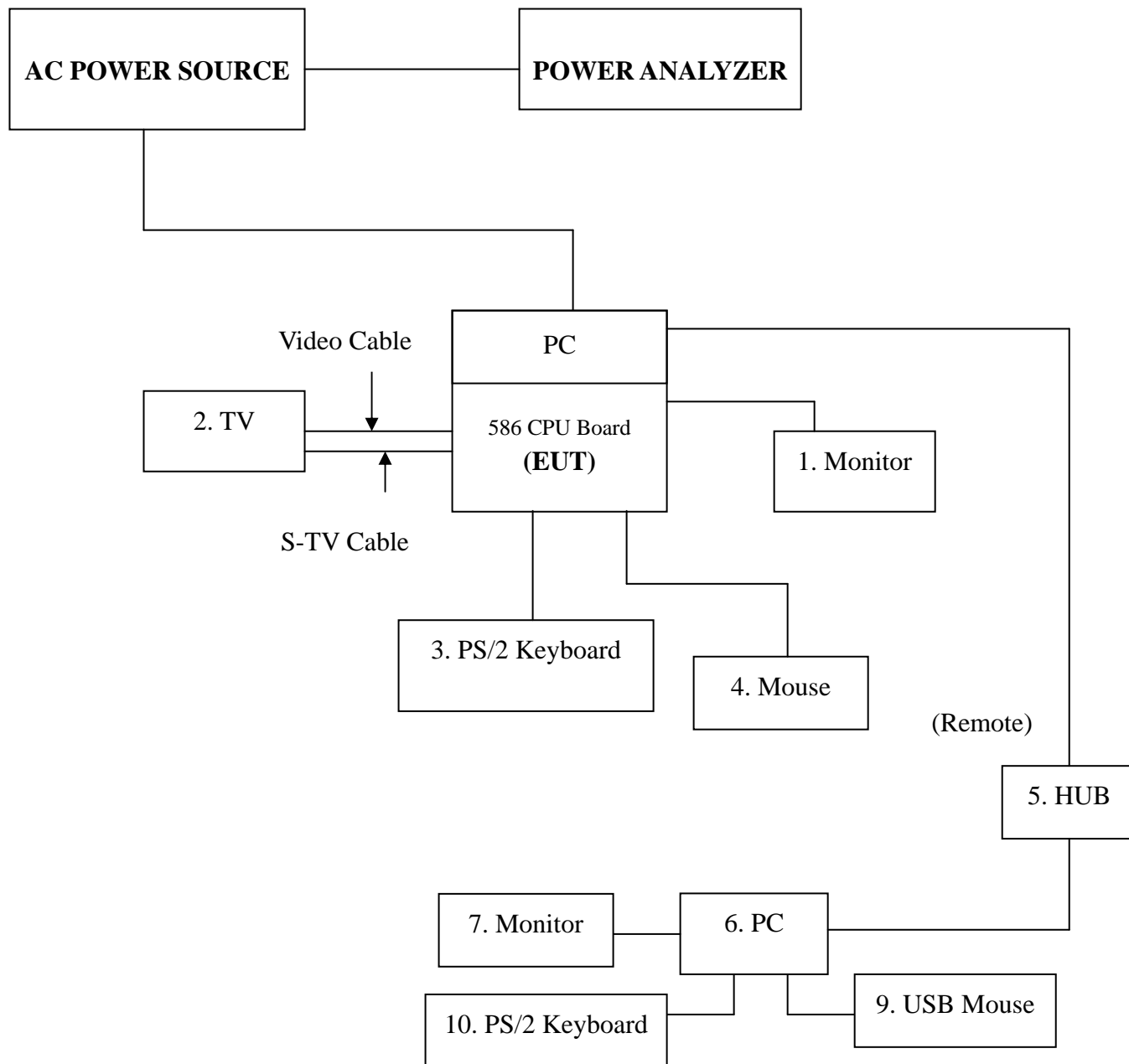
**Port** : AC mains  
**Basic Standard** : EN 61000-3-2: 1995 + A1: 1998 + A2: 1998  
**Limits** : ☒ Class A, ☐ Class D  
**Temperature** : 16°C  
**Humidity** : 60%

### VOLTAGE FLUCTUATION/FLICKER MEASUREMENT

**Port** : AC mains  
**Basic Standard** : EN 61000-3-3 (1995)  
**Limits** : §5 of EN 61000-3-3  
**Temperature** : 17°C  
**Humidity** : 59%



**Block Diagram of Test Setup:**



**Result:**

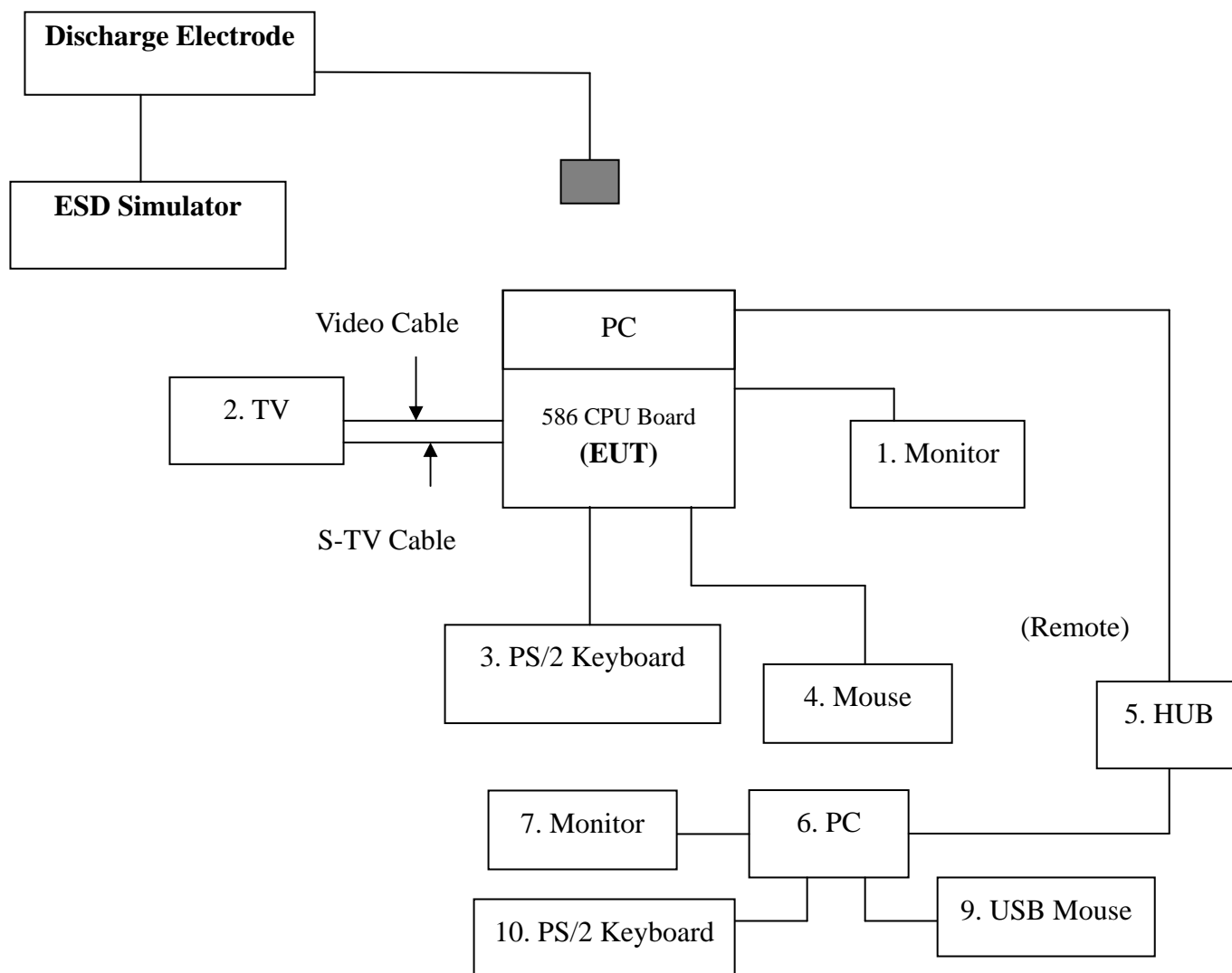
Please see the attached test data.

## SECTION 3 EN 61000-4-2 (ELECTROSTATIC DISCHARGE)

### ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

**Port** : Enclosure  
**Basic Standard** : EN 61000-4-2  
**Requirements** :  $\pm 8\text{kV}$  (Air Discharge)  
                           $\pm 4\text{kV}$  (Contact Discharge)  
                           $\pm 4\text{kV}$  (Indirect Discharge)  
**Performance Criteria** : B (Standard Required)  
**Temperature/Humidity**:  $17^{\circ}\text{C}$  / 55%

#### Block Diagram of Test Setup:



## **Test Procedure:**

The electrostatic discharges were applied as follows:

Amount of Discharges	Voltage	Coupling	Result (Pass/Fail)
$\geq 10$ Point	$\pm 8\text{kV}$	Air Discharge	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Contact Discharge	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Front)	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Left)	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Back)	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge HCP (Right)	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Front)	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Left)	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Back)	Pass
$\geq 10$ /Point	$\pm 4\text{kV}$	Indirect Discharge VCP (Right)	Pass

**\*\* The tested points to EUT, please refer to attached pages.**

## **Performance & Result:**

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**\*\*Observation:** No any function degraded during the tests.

***The Tested Points of EUT***

***(Photo 1 of 3)***



***(Photo 2 of 3)***



***(Photo 3 of 3)***



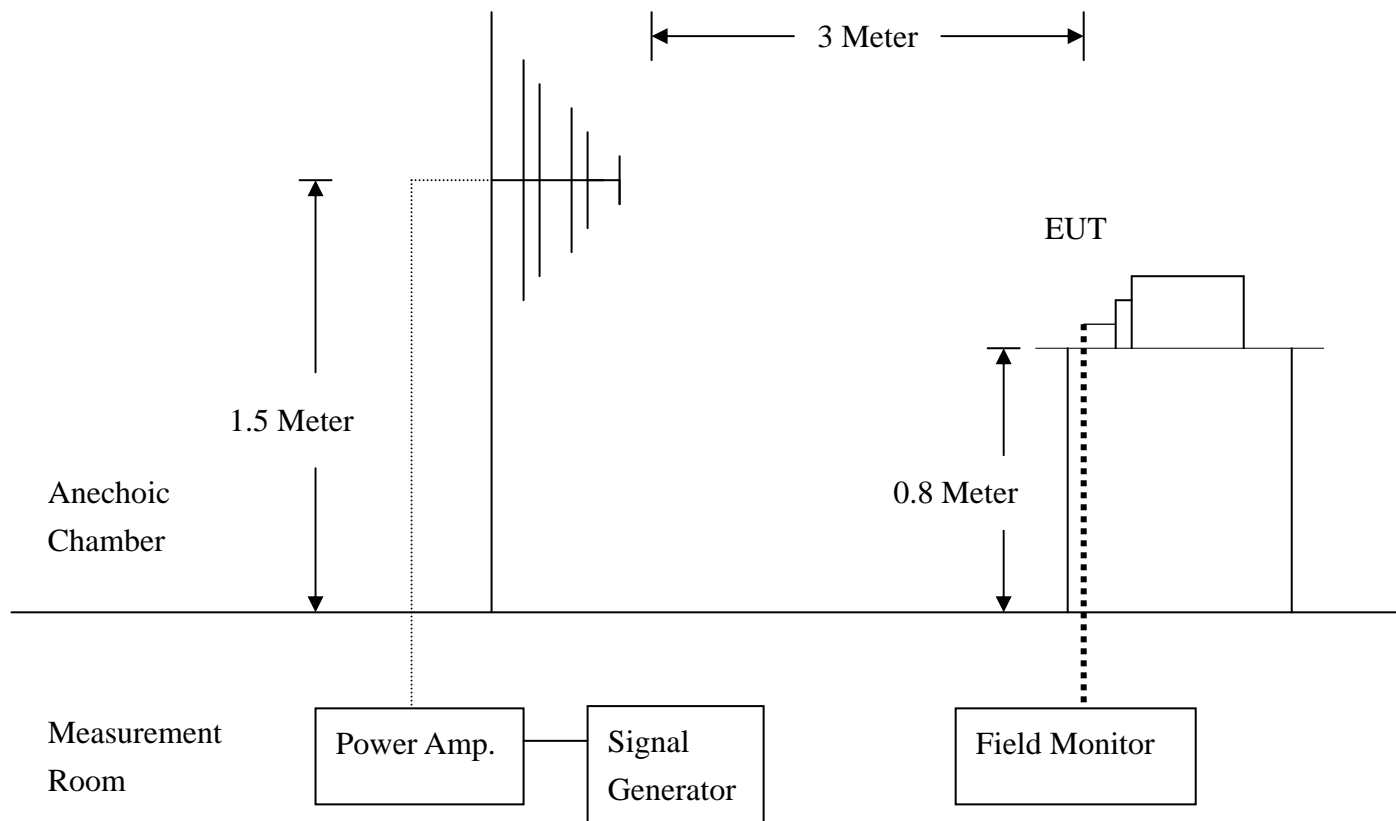
## SECTION 4 ENV 50140 (RADIATED ELECTROMAGNETIC FIELD )

### RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

<b>Port</b>	: Enclosure
<b>Basic Standard</b>	: ENV 50140
<b>Requirements</b>	: 10 V/m / Modulated
<b>Performance Criteria</b>	: A (Standard Required)
<b>Temperature</b>	: 18°C
<b>Humidity</b>	: 57%

#### Block Diagram of Test Setup:

Same as Section 3 EN 61000-4-2 Test Setup:



## Test Procedure:

Frequency Range : 80MHz-1000MHz

Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	10V	Yes	H	0	Pass
80-1000	10V	Yes	V	0	Pass
80-1000	10V	Yes	H	90	Pass
80-1000	10V	Yes	V	90	Pass
80-1000	10V	Yes	H	180	Pass
80-1000	10V	Yes	V	180	Pass
80-1000	10V	Yes	H	270	Pass
80-1000	10V	Yes	V	270	Pass

## Performance & Result:

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**\*\*Observation:** No any function degraded during the tests.

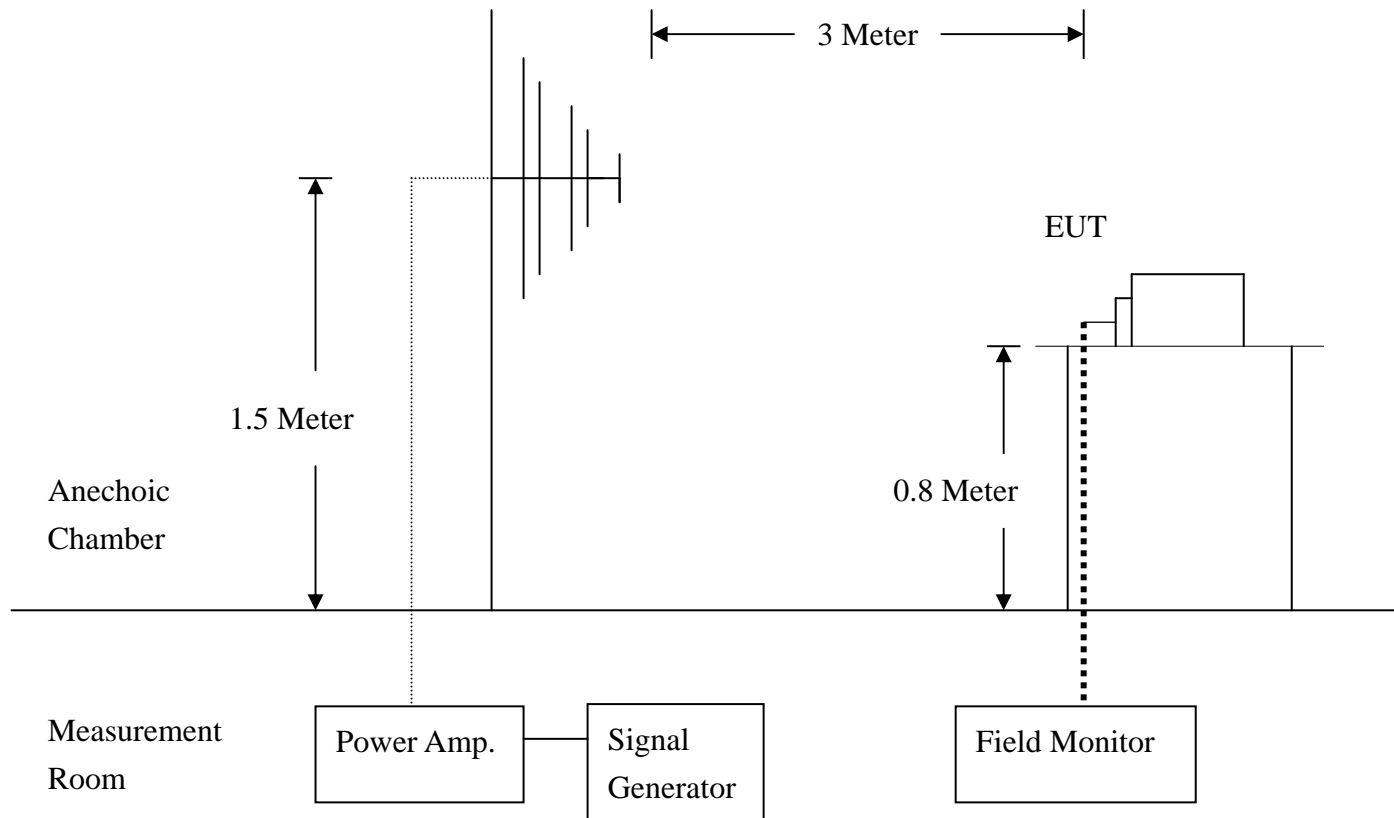
## SECTION 5 ENV 50204 (RADIATED ELECTROMAGNETIC FIELD FROM DIGITAL TELEPHONES )

### Radiated Electromagnetic Field From Digital Telephones Immunity Test

<b>Port</b>	: Enclosure
<b>Basic Standard</b>	: ENV 50204
<b>Requirements</b>	: 10 V/m, with modulated
<b>Performance Criteria</b>	: A (Standard Required)
<b>Temperature</b>	: 18°C
<b>Humidity</b>	: 57%

### Block Diagram of Test Setup:

Same as Section 3 EN 61000-4-2 Test Setup:





## **Test Procedure:**

Spot Frequency : 900 MHz  $\pm$  5MHz

Modulated Frequency : 200 Hz

Duty cycle : 50%

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
900 $\pm$ 5	10V	Yes	H	0	Pass
900 $\pm$ 5	10V	Yes	V	0	Pass
900 $\pm$ 5	10V	Yes	H	90	Pass
900 $\pm$ 5	10V	Yes	V	90	Pass
900 $\pm$ 5	10V	Yes	H	180	Pass
900 $\pm$ 5	10V	Yes	V	180	Pass
900 $\pm$ 5	10V	Yes	H	270	Pass
900 $\pm$ 5	10V	Yes	V	270	Pass

## **Performance & Result:**

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**\*\*Observation:** No any function degraded during the tests.

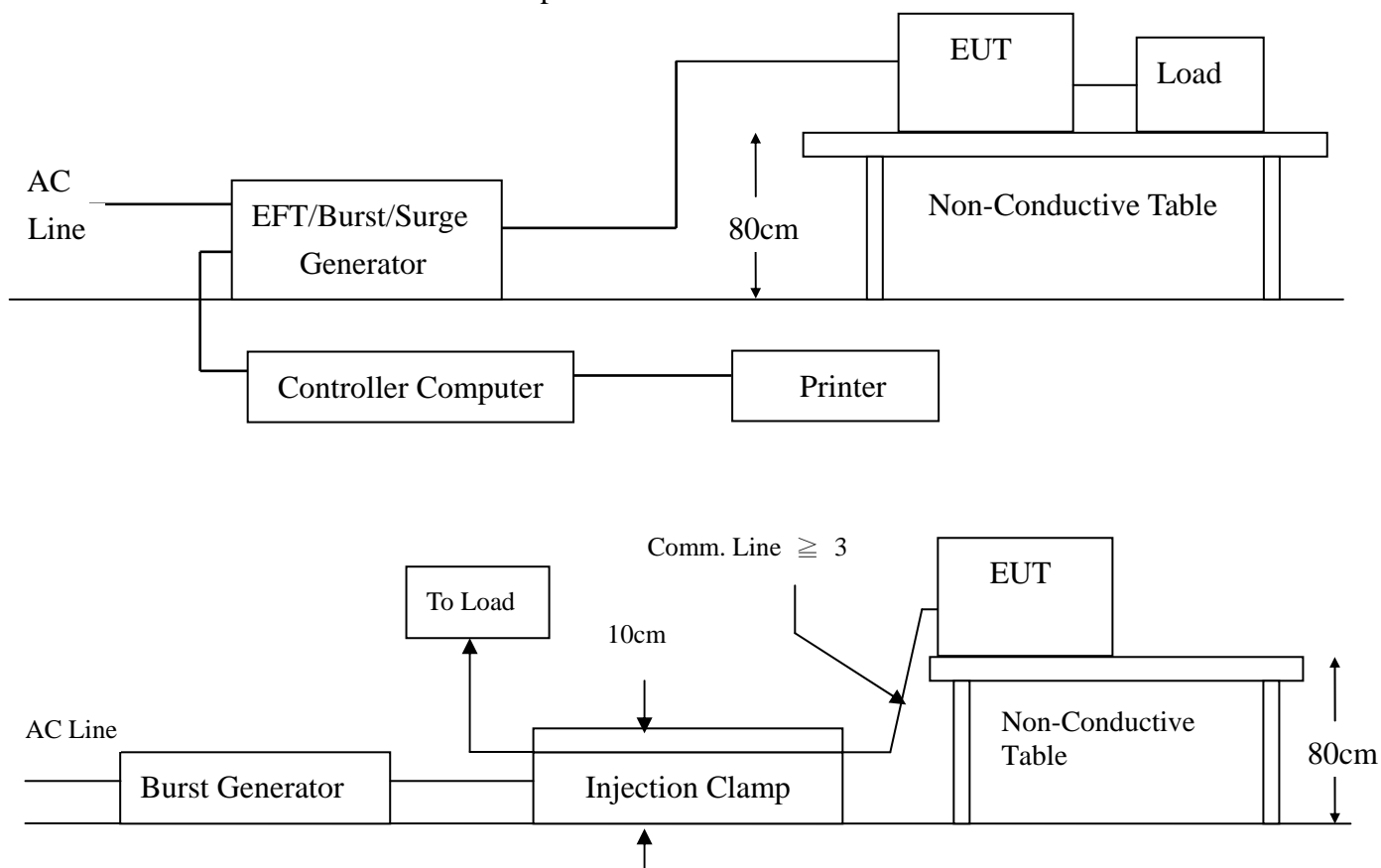
## SECTION 6 EN 61000-4-4 (FAST TRANSIENTS/BURST)

### FAST TRANSIENTS/BURST IMMUNITY TEST

<b>Port</b>	: On Power Port and Data Cable
<b>Basic Standard</b>	: EN 61000-4-4
<b>Requirements</b>	: $\pm 2\text{kV}$ for Power Port $\pm 1\text{kV}$ for LAN Cable
<b>Performance Criteria</b>	: B (Standard require)
<b>Temperature</b>	: $18^{\circ}\text{C}$
<b>Humidity</b>	: 53%

#### Block Diagram of Test Setup:

Same as Section 3 EN 61000-4-2 Test Setup:



## **Test Procedure:**

Impulse Frequency: 5kHz

Tr/Tn: 5/50ns

Burst Duration: 15ms

Burst Period: 3Hz

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L1	$\pm 2$	Direct	Pass
N	$\pm 2$	Direct	Pass
PE	$\pm 2$	Direct	Pass
L1 + N	$\pm 2$	Direct	Pass
L1 + PE	$\pm 2$	Direct	Pass
N + PE	$\pm 2$	Direct	Pass
L1 + N + PE	$\pm 2$	Direct	Pass
LAN	$\pm 1$	Clamp	Pass

## **Performance & Result:**

- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

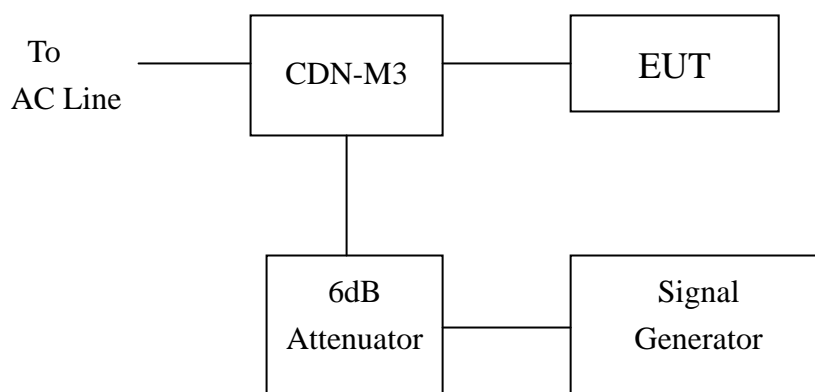
**\*\*Observation:** No any function degraded during the tests.

## SECTION 7 ENV 50141 (CONDUCTED DISTURBANCE/INDUCED BY RADIO-FREQUENCY FIELD)

**Port** : Power cord  
**Basic Standard** : ENV 50141  
**Requirements** : 10 V with Modulated  
**Injection Method** : CDN-M3  
**Performance Criteria** : A  
**Temperature** : 17°C  
**Humidity** : 55%

### Block Diagram of Test Setup:

Same as Section 3 EN 61000-4-2 Test Setup:



## **Test Procedure:**

Frequency Range : 0.15MHz-80MHz  
Frequency Step : 1% of fundamental  
Dwell Time : 1 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	10V	Yes	Pass

## **Performance & Result:**

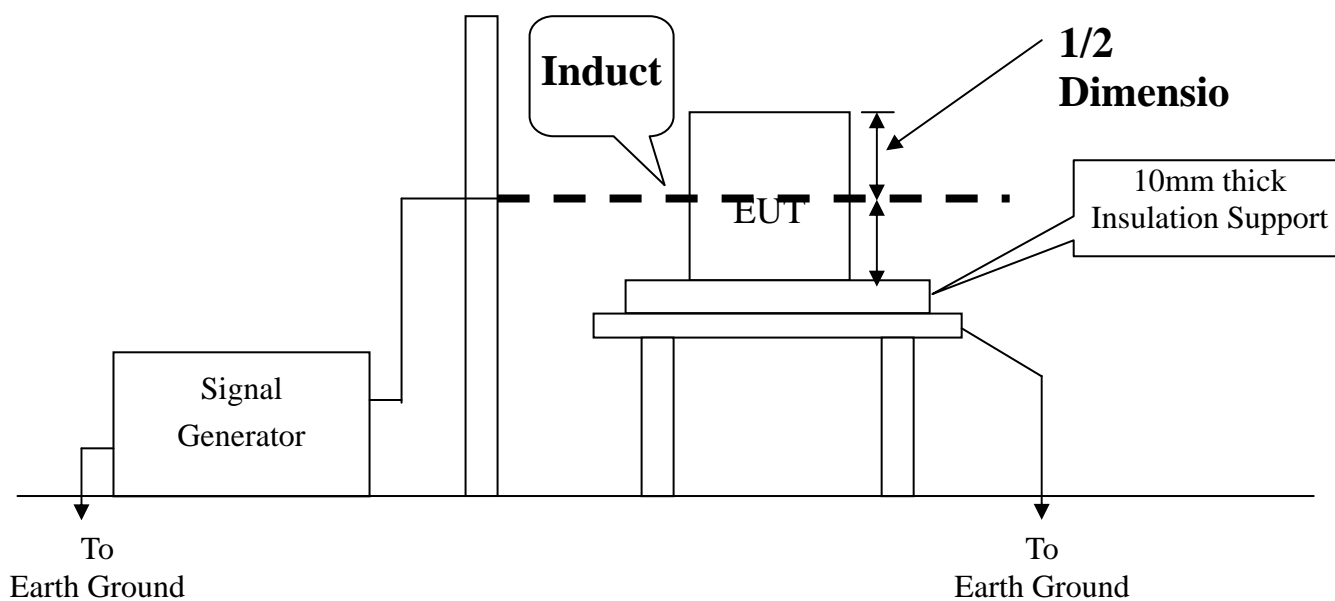
- ☒ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**\*\*Observation:** No any function degraded during the tests.

## SECTION 9 EN 61000-4-8 (POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST)

**Port** : Enclosure  
**Basic Standard** : EN 61000-4-8  
**Requirements** : 3 A/m  
**Performance Criteria** : A (Standard Required)  
**Temperature** : N/A  
**Humidity** : N/A

### Block Diagram of Test Setup:



## Test Procedure:

**Field Strength:** 3A/m  
**Power Freq.:** 50Hz  
**Orientation:** X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark

**\*\*Note:** Not applicable, because no any component can be influenced by power magnetic fields.

## Performance & Result:

- ☐ **Criteria A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criteria B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criteria C:** Temporary loss of function is allowed, provided the functions self-recoverable or can be restored by the operation of controls.

**\*\*Observation:** N/A

## **APPENDIX 1**

### **PHOTOGRAPHS OF TEST SETUP**



## LINE CONDUCTED EMISSION TEST (EN 55022)



## RADIATED EMISSION TEST (EN 55011)

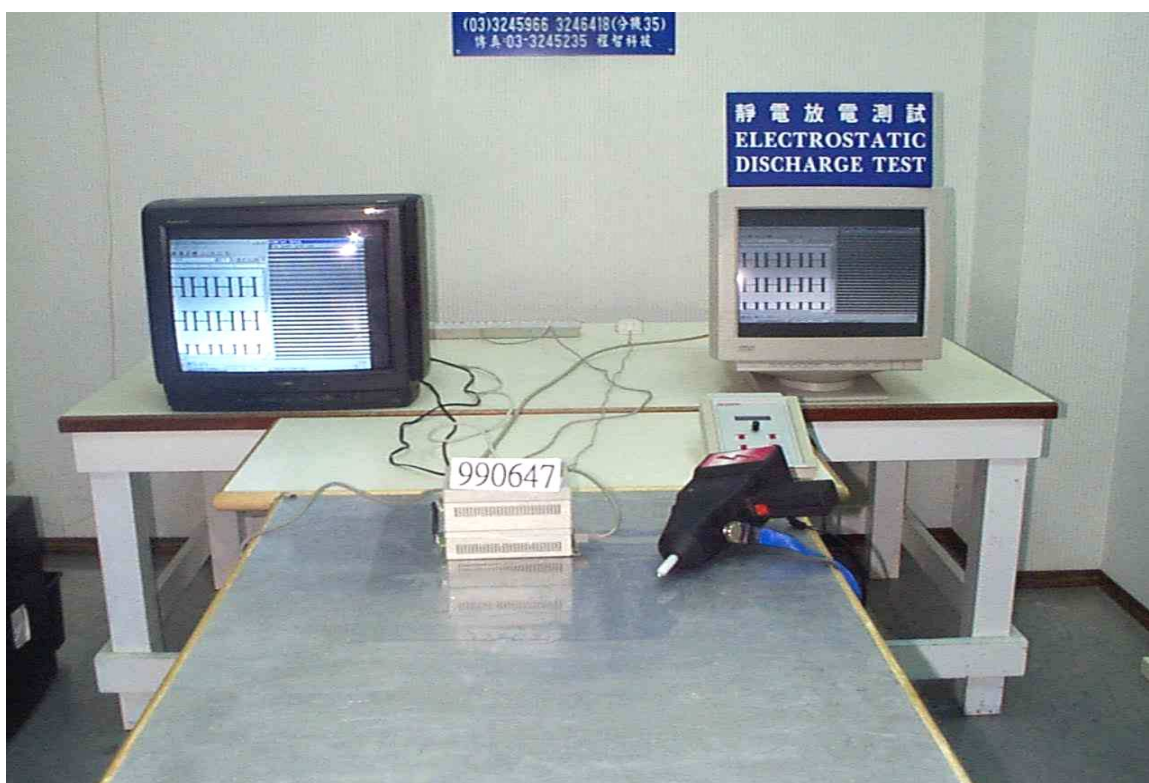


## POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST (EN 61000-3-2, EN 61000-3-3)

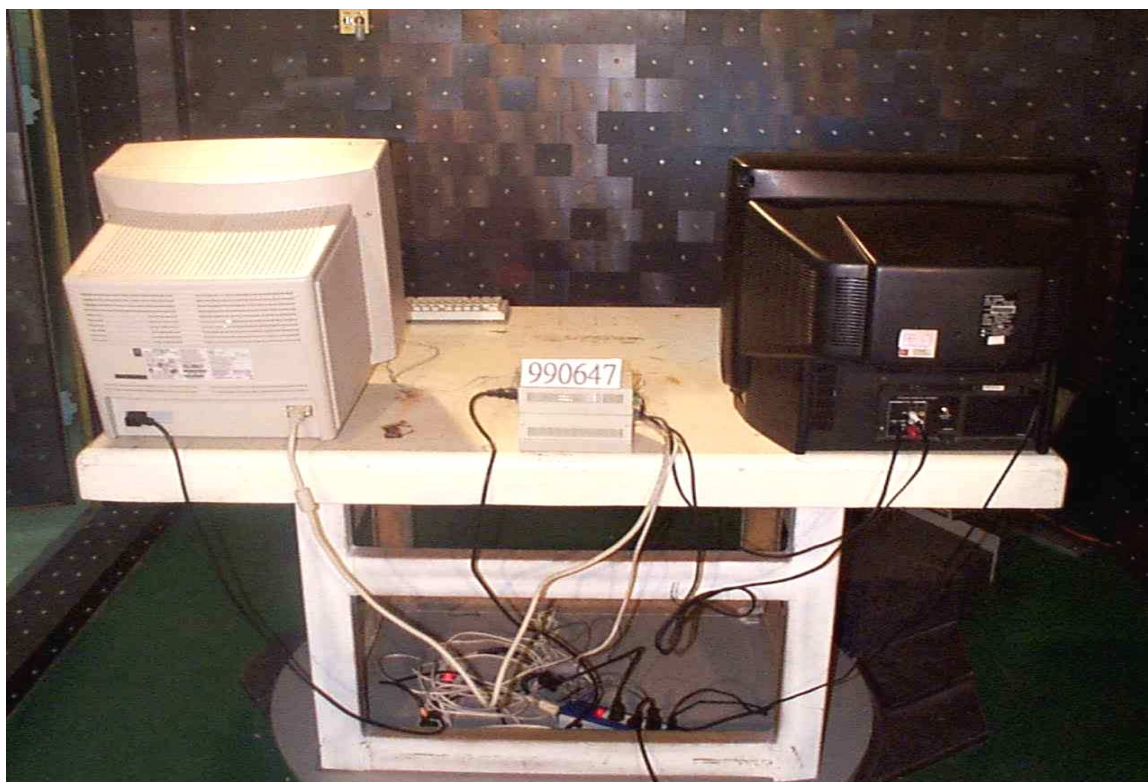




## ELECTROSTATIC DISCHARGE TEST (EN 61000-4-2)



## **RADIATED ELECTROMAGNETIC FIELD (ENV 50140 & ENV 50204)**

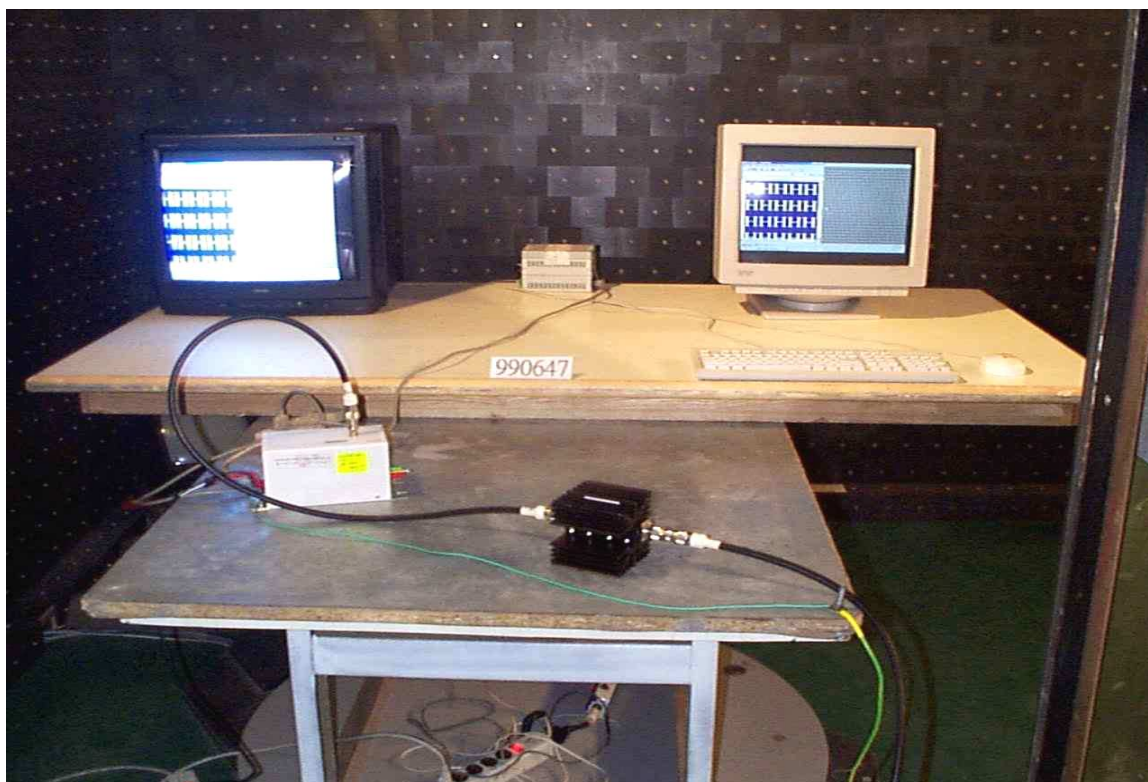




## FAST TRANSIENTS/BURST TEST (EN 61000-4-4)



## CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST (ENV 50141)



## **APPENDIX 2**

### **PHOTOGRAPHS OF EUT**



Front View of PC



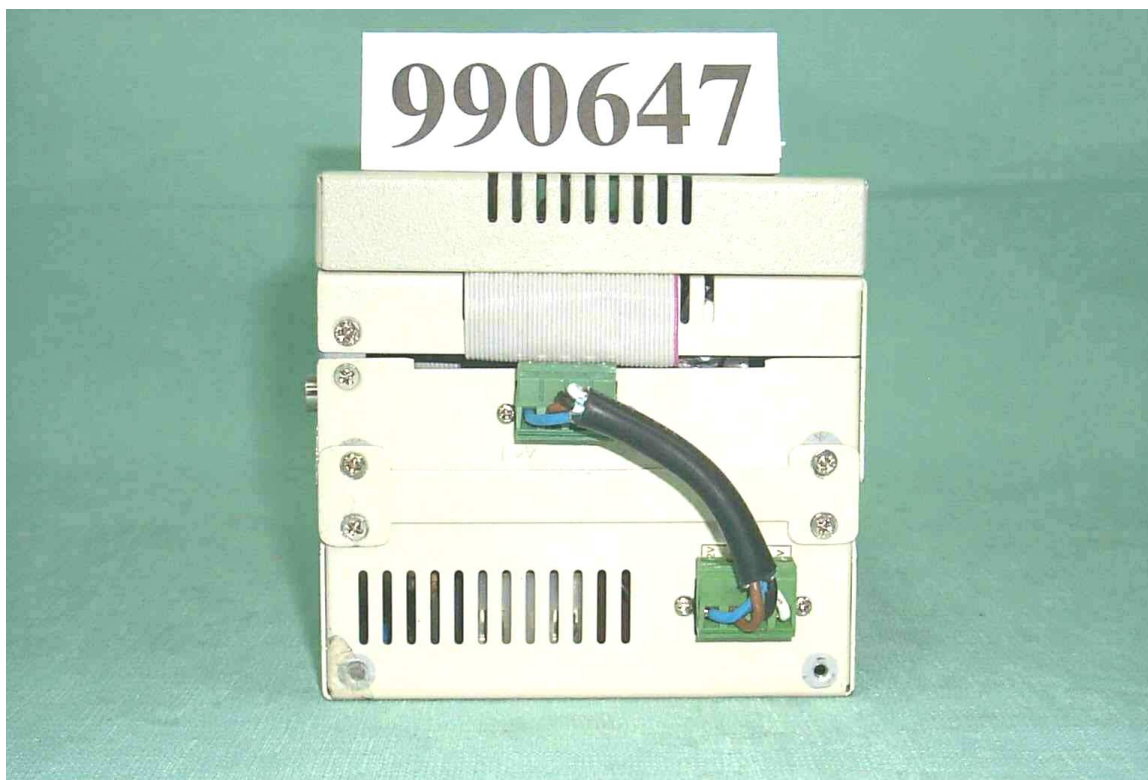
Rear View of PC



Right View of PC



Left View of PC





**Front View of EUT**



**Rear View of EUT**



**Front View of I/O Port on EUT**

